Power MOSFET

-20 V, -15 A, Single P-Channel, μ8FL

Features

- Ultra Low R_{DS(on)} to Minimize Conduction Losses
- μ8FL 3.3 x 3.3 x 0.8 mm for Space Saving and Excellent Thermal Conduction
- ESD Protection Level of 5 kV per JESD22-A114
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- Battery Switch
- High Side Load Switch
- Optimized for Power Management Applications for Portable Products such as Media Tablets, Ultrabook PCs and Cellphones

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Paran	Symbol	Value	Unit		
Drain-to-Source Voltage			V_{DSS}	-20	٧
Gate-to-Source Voltage			V _{GS}	±8	٧
Continuous Drain		T _A = 25°C	I _D	-15	Α
Current R _{θJA} (Note 1)		T _A = 85°C		-11	
Power Dissipation $R_{\theta JA}$ (Note 1)		T _A = 25°C	P _D	2.3	W
Continuous Drain		T _A = 25°C	I _D	-22	Α
Current $R_{\theta JA} \le 10 \text{ s}$ (Note 1)	Steady	T _A = 85°C		-16	
Power Dissipation $R_{\theta JA} \le 10 \text{ s (Note 1)}$	State	T _A = 25°C	P _D	4.9	W
Continuous Drain		T _A = 25°C	I _D	-9	Α
Current R _{θJA} (Note 2)		T _A = 85°C		-7	
Power Dissipation R _{θJA} (Note 2)	_	T _A = 25°C	P _D	0.84	W
Pulsed Drain Current $T_A = 25^{\circ}C$, $t_p = 10 \mu s$			I _{DM}	-46	Α
Operating Junction and Storage Temperature			T _J , T _{stg}	-55 to +150	°C
ESD (HBM, JESD22-A114)			V _{ESD}	5000	V
Source Current (Body Diode)			I _S	-3	Α
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- 1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
- 2. Surface-mounted on FR4 board using the minimum recommended pad size.

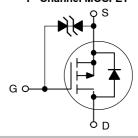


ON Semiconductor®

http://onsemi.com

V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX	
-20 V	6.7 m Ω @ –4.5 V	–15 A	
	9.0 mΩ @ -2.5 V	-137	

P-Channel MOSFET





(μ8FL)

MARKING DIAGRAM s d D D D

3A08 s (S AYWW= D D CASE 511AB Gΰ D

> 3A08 = Specific Device Code Α = Assembly Location = Year WW

= Work Week = Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping [†]
NTTFS3A08PZTAG	WDFN8 (Pb-Free)	1500 / Tape & Reel
NTTFS3A08PZTWG	WDFN8 (Pb-Free)	5000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	55	°C/W
Junction-to-Ambient - Steady State (Note 4)	$R_{\theta JA}$	148	
Junction-to-Ambient - (t ≤ 10 s) (Note 3)	$R_{\theta JA}$	26	

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•		•		•		
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		-20			٧
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J	<u> </u>			6		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = -16 V	T _J = 25°C			-1	μΑ
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 V, V_{GS}$; = ±5 V			±5	μΑ
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{D} = -250 \mu A$		-0.4		-1.0	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				3.3		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = -4.5 V	I _D = -12 A		4.9	6.7	mΩ
		V _{GS} = -2.5 V	I _D = -10 A		6.9	9.0	
Forward Transconductance	9 _{FS}	V _{DS} = −1.5 V, I _E	_O = -8 A		62		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{iss}	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = -10 V			5000		pF
Output Capacitance	C _{oss}				600		
Reverse Transfer Capacitance	C _{rss}				540		
Total Gate Charge	Q _{G(TOT)}	$V_{GS} = -4.5 \text{ V}, V_{DS} = -10 \text{ V}, I_D = -8 \text{ A}$			56		nC
Threshold Gate Charge	Q _{G(TH)}				2.0		
Gate-to-Source Charge	Q_{GS}				6.5		
Gate-to-Drain Charge	Q_{GD}				15.4		
SWITCHING CHARACTERISTICS (Note	6)						
Turn-On Delay Time	t _{d(on)}				13		ns
Rise Time	t _r	$V_{GS} = -4.5 \text{ V}, V_{DS}$	_S = -10 V,		60		
Turn-Off Delay Time	t _{d(off)}	$V_{GS} = -4.5 \text{ V}, V_{DS} = -10 \text{ V},$ $I_D = -8 \text{ A}, R_G = 6.0 \Omega$			250		
Fall Time	t _f				170		
DRAIN-SOURCE DIODE CHARACTER	ISTICS						
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 \text{ V},$ $I_S = -3 \text{ A}$	T _J = 25°C		-0.65	-1.0	V
Reverse Recovery Time	t _{RR}		•		207		ns
Charge Time	ta	$V_{GS} = 0 \text{ V, } d_{IS}/d_t = 100 \text{ A/}\mu\text{s,}$ $I_S = -6 \text{ A}$			45]
Discharge Time	t _b				162]
Reverse Recovery Charge	Q _{RR}				234		nC
				_		_	

^{5.} Pulse Test: pulse width = 300 μ s, duty cycle \leq 2%.

Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size (40 mm², 1 oz. Cu).

^{6.} Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

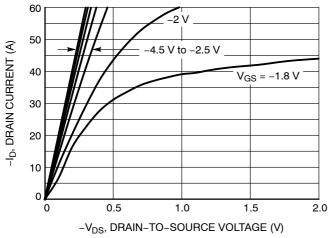


Figure 1. On-Region Characteristics

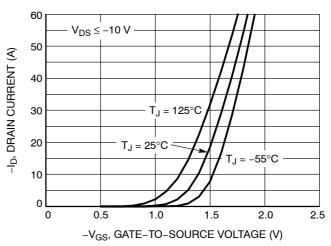


Figure 2. Transfer Characteristics

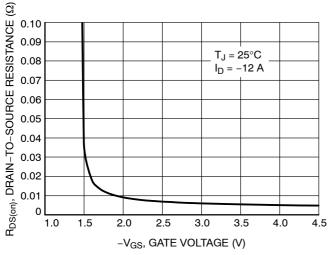


Figure 3. On-Resistance vs. Gate-to-Source Voltage

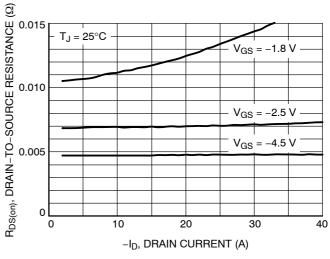


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

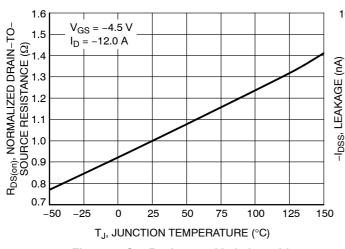


Figure 5. On–Resistance Variation with Temperature

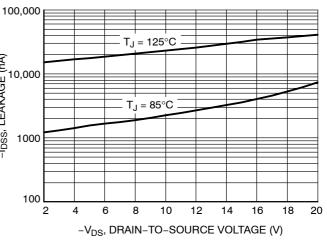


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

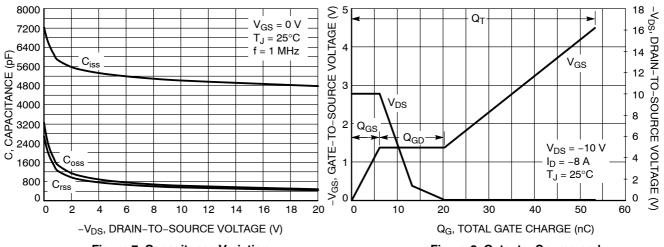


Figure 7. Capacitance Variation

Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

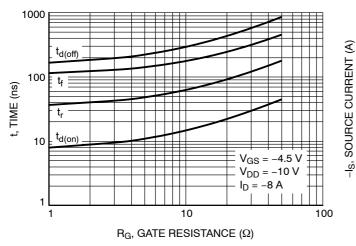


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

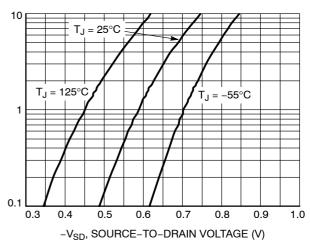


Figure 10. Diode Forward Voltage vs. Current

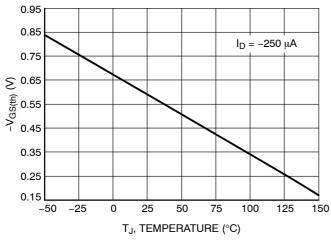


Figure 11. Threshold Voltage

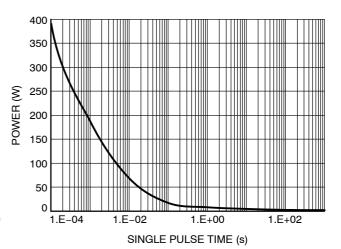


Figure 12. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS

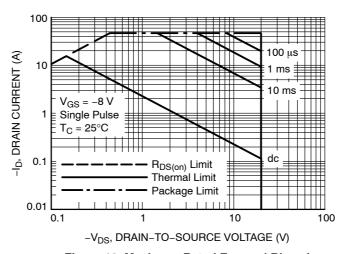


Figure 13. Maximum Rated Forward Biased Safe Operating Area

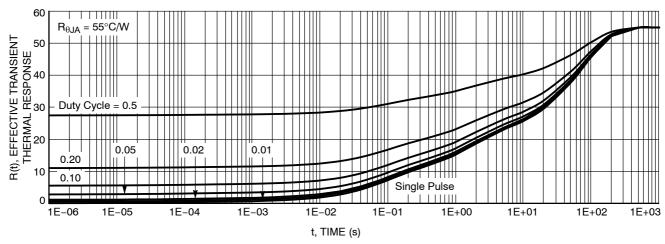
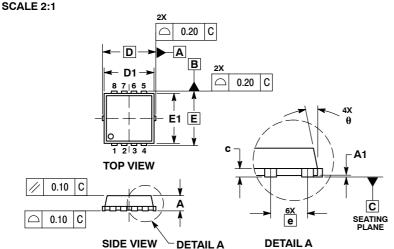


Figure 14. FET Thermal Response



WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D

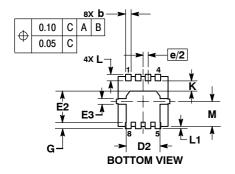
DATE 23 APR 2012



NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: MILLIMETERS.
 3. DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE BURRS.

	MILLIMETERS			INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.70	0.75	0.80	0.028	0.030	0.031	
A1	0.00		0.05	0.000		0.002	
b	0.23	0.30	0.40	0.009	0.012	0.016	
С	0.15	0.20	0.25	0.006	0.008	0.010	
D		3.30 BSC	;	0	.130 BSC)	
D1	2.95	3.05	3.15	0.116	0.120	0.124	
D2	1.98	2.11	2.24	0.078	0.083	0.088	
E		3.30 BSC			0.130 BSC		
E1	2.95	3.05	3.15	0.116	0.120	0.124	
E2	1.47	1.60	1.73	0.058	0.063	0.068	
E3	0.23	0.30	0.40	0.009	0.012	0.016	
е		0.65 BSC	;	0.026 BSC			
G	0.30	0.41	0.51	0.012	0.016	0.020	
K	0.65	0.80	0.95	0.026	0.032	0.037	
L	0.30	0.43	0.56	0.012	0.017	0.022	
L1	0.06	0.13	0.20	0.002	0.005	0.008	
M	1.40	1.50	1.60	0.055	0.059	0.063	
θ	0 °		12 °	0 °		12 °	



GENERIC MARKING DIAGRAM*



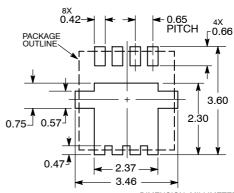
XXXXX = Specific Device Code = Assembly Location Α

= Year WW = Work Week = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking.

Pb-Free indicator, "G" or microdot " ■", may or may not be present.

SOLDERING FOOTPRINT*



DIMENSION: MILLIMETERS

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

DOCUMENT NUMBER:	98AON30561E	Electronic versions are uncontrolled except when accessed directly from the Document Reposi Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.		
DESCRIPTION:	WDFN8 3.3X3.3, 0.65P		PAGE 1 OF 1	

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